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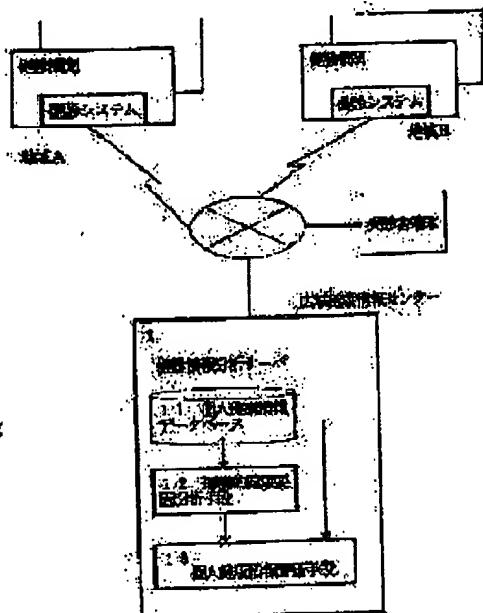
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(54) HEALTH EXAMINATION INFORMATION ANALYSIS SERVER AND NETWORK HEALTH INFORMATION SYSTEM

(57)Abstract:

PROBLEM TO BE SOLVED: To attain the evaluation of personal health information not only based on genetic health factors such as sex and age but also environmental health factors such as area characteristics and life characteristics among factors affecting the health states of personals.

SOLUTION: This system is provided with a health examination information analysis server 1 connected with plural health examination facilities in which the area characteristics or environmental characteristics of the lives of examinees are various, and provided with a wide area personal health information data base 11 for operating the unitary collection and storage of the personal health information of those facilities. This health examination information analysis server 1 is also provided with an environmental health factor analyzing means 12 for classifying and analyzing personal health examination data and health index values for each environmental health factor so that the personal health information can be evaluated, based on environmental health factors by obtaining each environmental factor health index distribution.



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